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Job No.:	SEM15078320	Date:	2015-08-29
Standard:		Test item:	ESD (IEC61000-4-2)
Temp. /Hum.(%RH):	23°C / 54%	Test By:	Jong
Client:	GlobTek		
Address:			
EUT:	ITE Power Adapter	Model:	GT*46101-***-USB
Test condition:	Full load		
Note:		Conclusion:	PASS

Test Data:

Table 1: Electrostatic Discharge Immunity (Air Discharge)

EN 61000-4-2 Test Points	Test Levels (kV)											
	-2	+2	-4	+4	-6	+6	-8	+8	-12	+12	-20	+20
Surface											A	A
Slit											A	A

Table 2: Electrostatic Discharge Immunity (Direct Contact)

EN 61000-4-2 Test Points	Test Levels (kV)									
	-2	+2	-4	+4	-6	+6	-8	+8	-15	+15
USB Port							A	A		

Performance Criteria:

- A. The apparatus shall continue to operate as intended during and after the test. The manufacturer specifies some minimum performance level. The performance level may be specified by the manufacturer as a permissible loss of performance.
- B. The apparatus shall continue to operate as intended after the test. This indicates that the EUT does not need to function at normal performance levels during the test, but must recover. Again some minimal performance is defined by the manufacture. No change in operating state or loss or data is permitted.
- C. Temporary loss of function is allowed. Operation of the EUT may stop as long as it is either automatically reset or can be manually restored by operation of the controls.